

CoolMOS™ Power Transistor

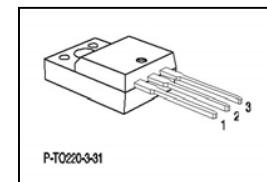
Features

- Lowest figure of merit $R_{ON} \times Q_g$
- Ultra low gate charge
- Extreme dv/dt rated
- High peak current capability
- Pb-free lead plating; RoHS compliant; Halogen free for mold compound
- Qualified for industrial grade applications according to JEDEC⁰⁾

Product Summary

| | | |
|---------------------|-------|----------|
| $V_{DS} @ T_{jmax}$ | 550 | V |
| $R_{DS(on),max}$ | 0.199 | Ω |
| $Q_{g,typ}$ | 34 | nC |

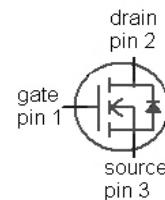
PG-T0220 Fullpack



CoolMOS CP is designed for:

- Hard and softswitching SMPS topologies
- CCM PFC for ATX, Notebook adapter, PDP and LCD TV
- PWM for ATX, Notebook adapter, PDP and LCD TV

| Type | Package | Marking |
|-------------|----------|---------|
| IPA50R199CP | PG-T0220 | 5R199P |



Maximum ratings, at $T_j=25^\circ\text{C}$, unless otherwise specified

| Parameter | Symbol | Conditions | Value | Unit |
|---|----------------|--|-------------|------|
| Continuous drain current ¹⁾ | I_D | $T_C=25^\circ\text{C}$ | 17 | A |
| | | $T_C=100^\circ\text{C}$ | 11 | |
| Pulsed drain current ²⁾ | $I_{D,pulse}$ | $T_C=25^\circ\text{C}$ | 40 | |
| Avalanche energy, single pulse | E_{AS} | $I_D=6.6\text{ A}, V_{DD}=50\text{ V}$ | 436 | mJ |
| Avalanche energy, repetitive t_{AR} ^{2),3)} | E_{AR} | $I_D=6.6\text{ A}, V_{DD}=50\text{ V}$ | 0.66 | |
| Avalanche current, repetitive t_{AR} ^{2),3)} | I_{AR} | | 6.6 | A |
| MOSFET dv/dt ruggedness | dv/dt | $V_{DS}=0\ldots400\text{ V}$ | 50 | V/ns |
| Gate source voltage | V_{GS} | static | ± 20 | V |
| | | AC ($f>1\text{ Hz}$) | ± 30 | |
| Power dissipation | P_{tot} | $T_C=25^\circ\text{C}$ | 139 | W |
| Operating and storage temperature | T_j, T_{stg} | | -55 ... 150 | °C |
| Mounting torque | | M2.5 screws | 60 | Ncm |

Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

| Parameter | Symbol | Conditions | Value | | Unit |
|--|---------------|--------------------------------|-------|--|------|
| Continuous diode forward current ¹⁾ | I_S | $T_C=25\text{ }^\circ\text{C}$ | 9.9 | | A |
| Diode pulse current ²⁾ | $I_{S,pulse}$ | | 40 | | |
| Reverse diode dv/dt ⁴⁾ | dv/dt | | 15 | | V/ns |

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Thermal characteristics

| | | | | | | |
|---|------------|--|---|---|-----|------------------|
| Thermal resistance, junction - case | R_{thJC} | | - | - | 3.7 | K/W |
| Thermal resistance, junction - ambient | R_{thJA} | leaded | - | - | 62 | |
| Soldering temperature, wavesoldering only allowed at leads | T_{sold} | 1.6 mm (0.063 in.) from case for 10 s | - | - | 260 | $^\circ\text{C}$ |

Electrical characteristics, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Static characteristics

| | | | | | | |
|----------------------------------|---------------|---|-----|------|-------|---------------|
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}, I_D=250\text{ }\mu\text{A}$ | 500 | - | - | V |
| Gate threshold voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}, I_D=0.66\text{ mA}$ | 2.5 | 3 | 3.5 | |
| Zero gate voltage drain current | I_{DSS} | $V_{DS}=500\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ }^\circ\text{C}$ | - | - | 1 | μA |
| | | $V_{DS}=500\text{ V}, V_{GS}=0\text{ V}, T_j=150\text{ }^\circ\text{C}$ | - | 10 | - | |
| Gate-source leakage current | I_{GSS} | $V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$ | - | - | 100 | nA |
| Drain-source on-state resistance | $R_{DS(on)}$ | $V_{GS}=10\text{ V}, I_D=9.9\text{ A}, T_j=25\text{ }^\circ\text{C}$ | - | 0.18 | 0.199 | Ω |
| | | $V_{GS}=10\text{ V}, I_D=9.9\text{ A}, T_j=150\text{ }^\circ\text{C}$ | - | 0.45 | - | |
| Gate resistance | R_G | $f=1\text{ MHz, open drain}$ | - | 2.2 | - | Ω |

| Parameter | Symbol | Conditions | Values | | | Unit |
|-----------|--------|------------|--------|------|------|------|
| | | | min. | typ. | max. | |

Dynamic characteristics

| | | | | | | |
|--|--------------|---|---|------|---|----|
| Input capacitance | C_{iss} | $V_{GS}=0 \text{ V}, V_{DS}=100 \text{ V}, f=1 \text{ MHz}$ | - | 1800 | - | pF |
| Output capacitance | C_{oss} | | - | 80 | - | |
| Effective output capacitance, energy related ⁵⁾ | $C_{o(er)}$ | $V_{GS}=0 \text{ V}, V_{DS}=0 \text{ V}$ to 400 V | - | 75 | - | |
| Effective output capacitance, time related ⁶⁾ | $C_{o(tr)}$ | | - | 160 | - | |
| Turn-on delay time | $t_{d(on)}$ | $V_{DD}=400 \text{ V}, V_{GS}=10 \text{ V}, I_D=9.9 \text{ A}, R_G=16.4 \Omega$ | - | 35 | - | ns |
| Rise time | t_r | | - | 14 | - | |
| Turn-off delay time | $t_{d(off)}$ | | - | 80 | - | |
| Fall time | t_f | | - | 10.0 | - | |

Gate Charge Characteristics

| | | | | | | |
|-----------------------|---------------|--|---|-----|----|----|
| Gate to source charge | Q_{gs} | $V_{DD}=400 \text{ V}, I_D=9.9 \text{ A}, V_{GS}=0 \text{ to } 10 \text{ V}$ | - | 8 | - | nC |
| Gate to drain charge | Q_{gd} | | - | 11 | - | |
| Gate charge total | Q_g | | - | 34 | 45 | |
| Gate plateau voltage | $V_{plateau}$ | | - | 5.2 | - | |

Reverse Diode

| | | | | | | |
|-------------------------------|-----------|---|---|-----|-----|---|
| Diode forward voltage | V_{SD} | $V_{GS}=0 \text{ V}, I_F=9.9 \text{ A}, T_j=25^\circ\text{C}$ | - | 0.9 | 1.2 | V |
| Reverse recovery time | t_{rr} | | - | 340 | - | |
| Reverse recovery charge | Q_{rr} | | - | 4 | - | |
| Peak reverse recovery current | I_{rrm} | | - | 24 | - | |

⁰⁾ J-STD20 and JESD22

¹⁾ Limited only by maximum temperature

²⁾ Pulse width t_p limited by $T_{j,max}$
³⁾ Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR} \cdot f$.

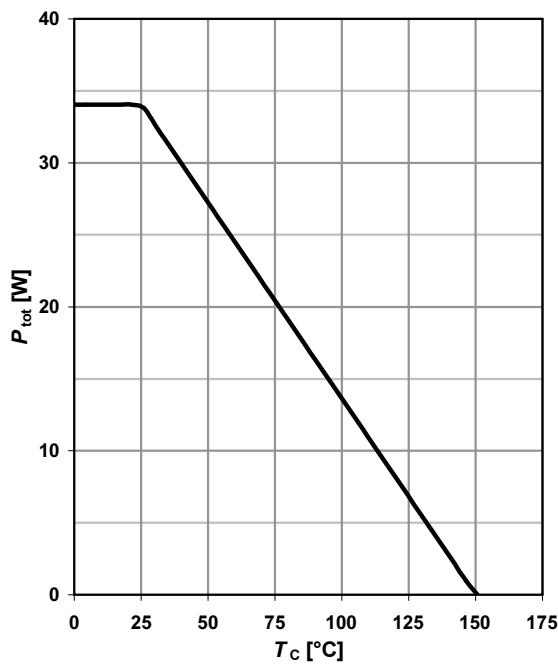
⁴⁾ $I_{SD} \leq I_D$, $di/dt \leq 200 \text{ A}/\mu\text{s}$, $V_{DClink}=400 \text{ V}$, $V_{peak} < V_{(BR)DSS}$, $T_j < T_{j,max}$, identical low and high side switch

⁵⁾ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

⁶⁾ $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

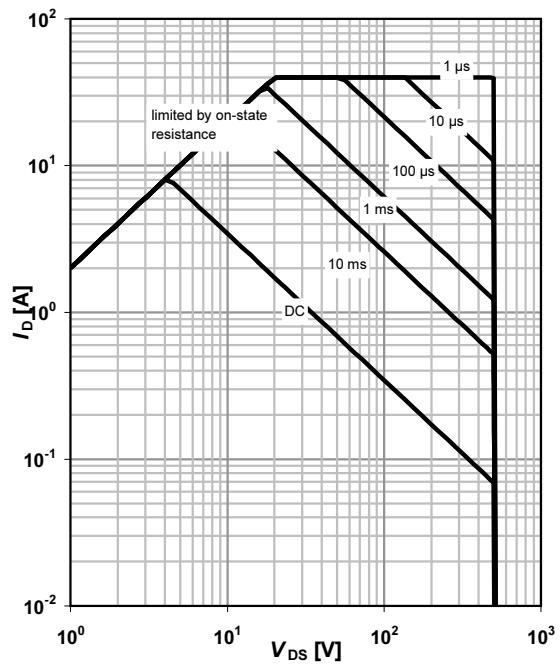
1 Power dissipation

$$P_{\text{tot}} = f(T_C)$$


2 Safe operating area

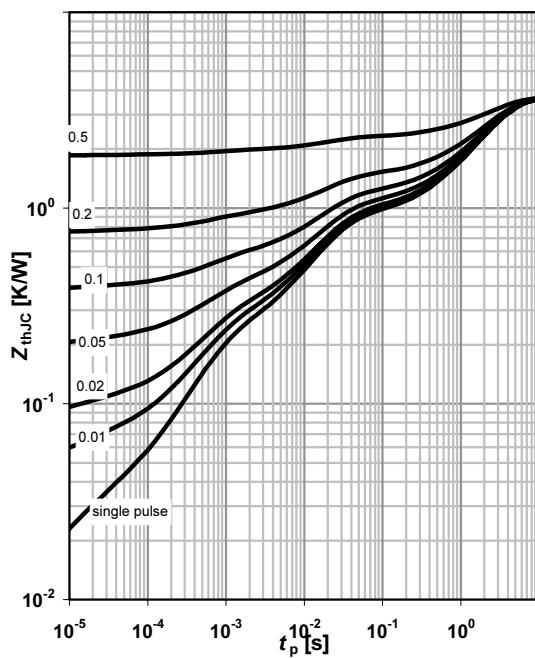
$$I_D = f(V_{DS}); \quad T_C = 25 \text{ °C}; \quad D = 0$$

parameter: t_p


3 Max. transient thermal impedance

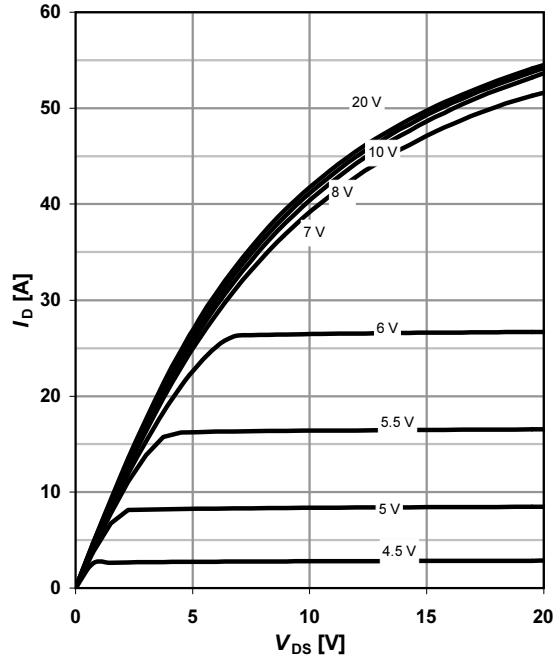
$$Z_{(\text{thJC})} = f(t_p);$$

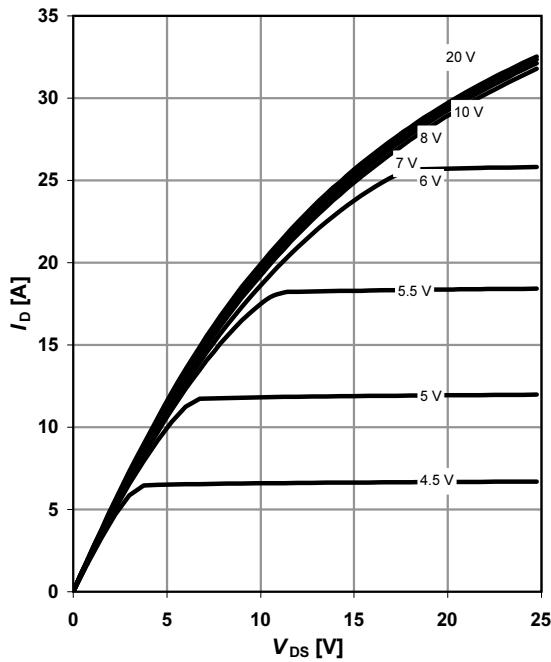
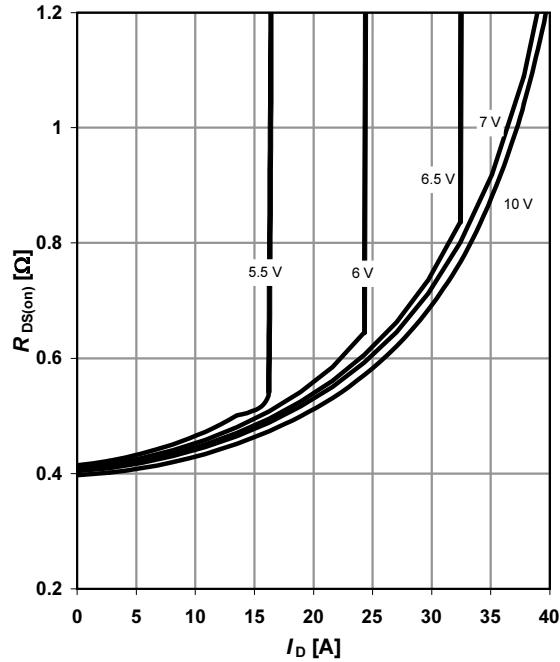
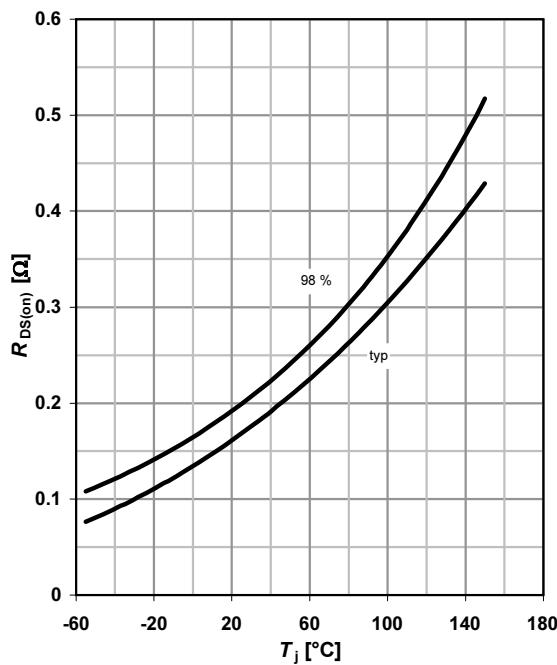
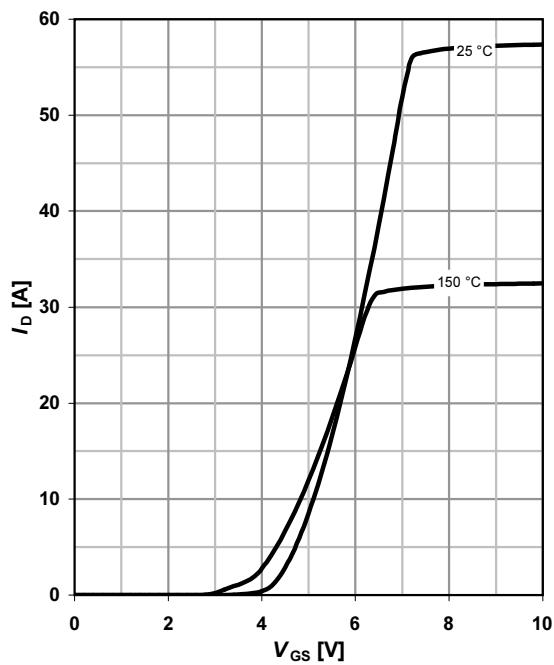
parameter: $D = t_p/T$


4 Typ. output characteristics

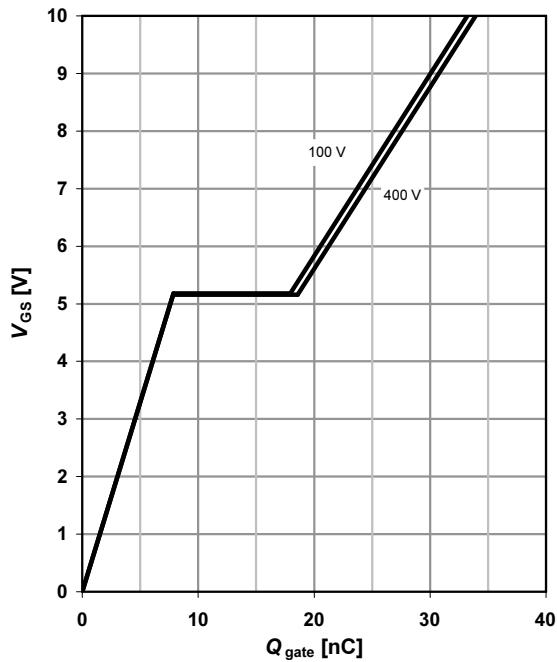
$$I_D = f(V_{DS}); \quad T_j = 25 \text{ °C}$$

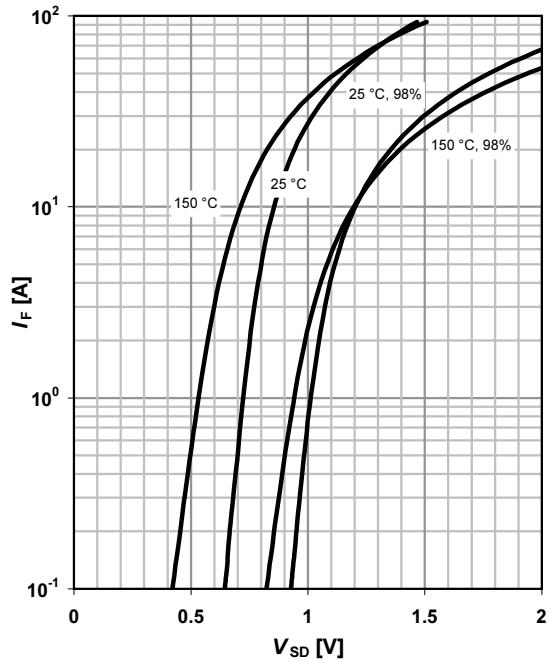
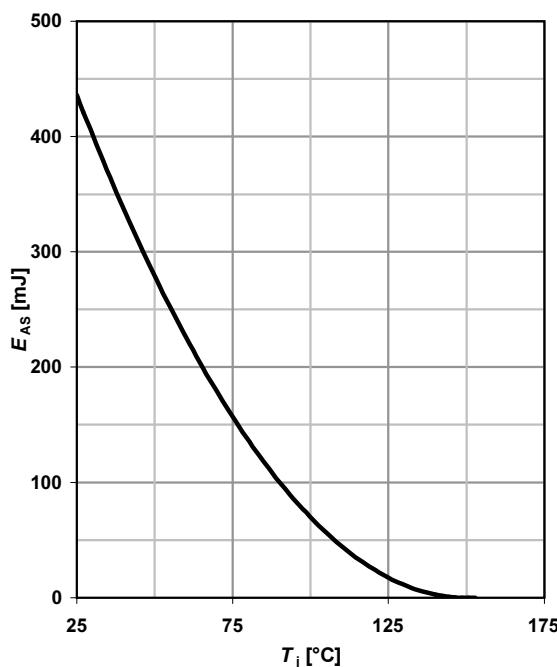
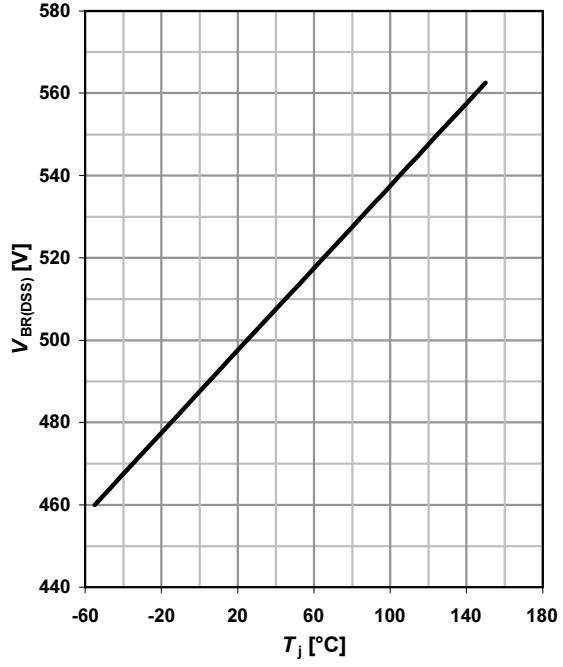
parameter: V_{GS}

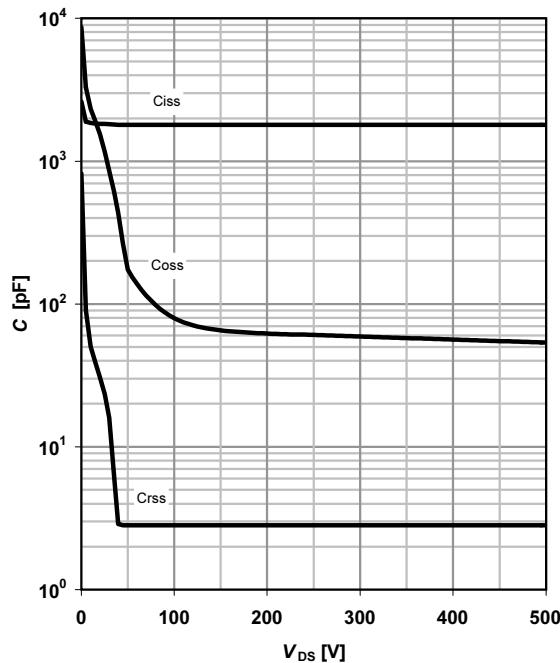
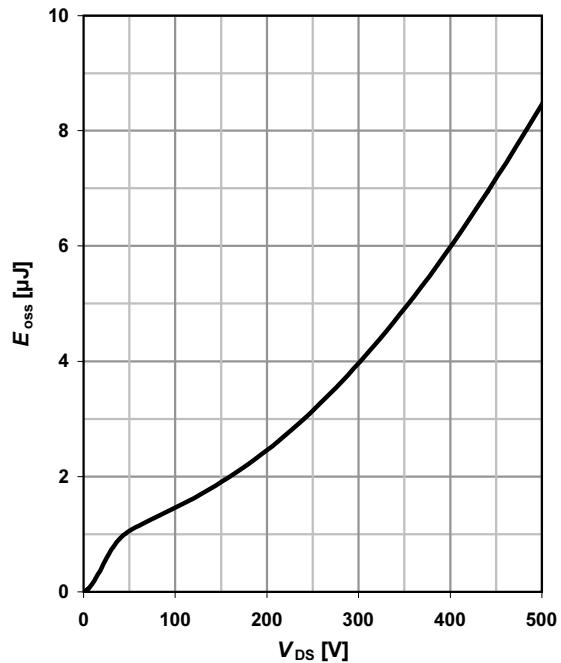


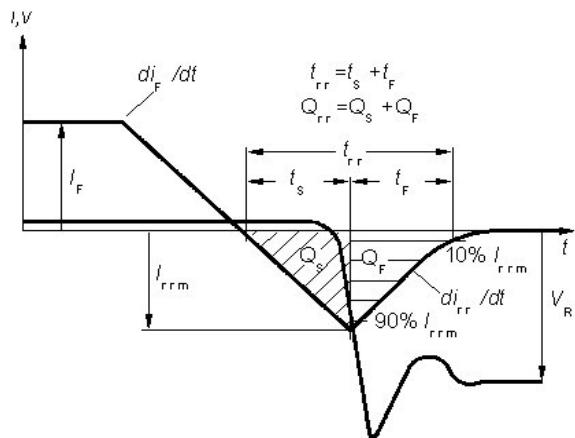
5 Typ. output characteristics
 $I_D = f(V_{DS})$; $T_j = 150 \text{ }^\circ\text{C}$
parameter: V_{GS} 
6 Typ. drain-source on-state resistance
 $R_{DS(on)} = f(I_D)$; $T_j = 150 \text{ }^\circ\text{C}$
parameter: V_{GS} 
7 Drain-source on-state resistance
 $R_{DS(on)} = f(T_j)$; $I_D = 9.9 \text{ A}$; $V_{GS} = 10 \text{ V}$

8 Typ. transfer characteristics
 $I_D = f(V_{GS})$; $|V_{DS}| > 2|I_D|R_{DS(on)max}$
parameter: T_j 

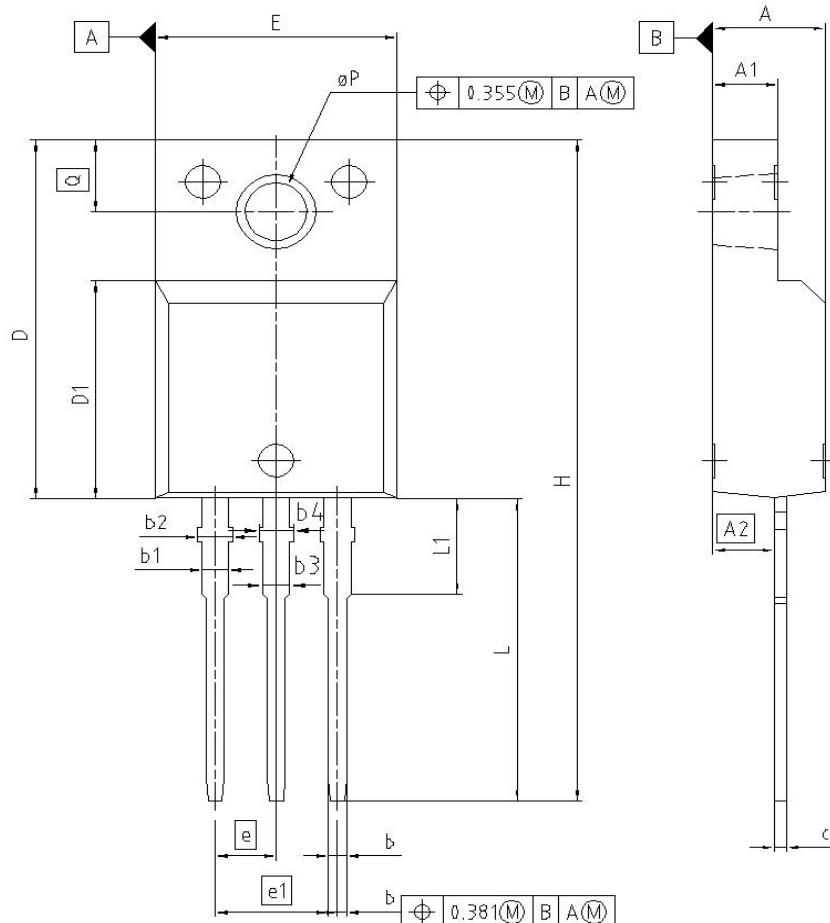
9 Typ. gate charge
 $V_{GS} = f(Q_{gate})$; $I_D = 9.9 \text{ A}$ pulsed

parameter: V_{DD}

10 Forward characteristics of reverse diode
 $I_F = f(V_{SD})$

parameter: T_j

11 Avalanche energy
 $E_{AS} = f(T_j)$; $I_D = 6.6 \text{ A}$; $V_{DD} = 50 \text{ V}$

12 Drain-source breakdown voltage
 $V_{BR(DSS)} = f(T_j)$; $I_D = 0.25 \text{ mA}$


13 Typ. capacitances
 $C=f(V_{DS})$; $V_{GS}=0$ V; $f=1$ MHz

14 Typ. Coss stored energy
 $E_{oss}=f(V_{DS})$


Definition of diode switching characteristics


PG-T0220-3-31;-3-111: Outline / Fully isolated package (2500VAC; 1minute)


| DIM | MILLIMETERS | | INCHES | | REFERENCE ... SCALE |
|-----|-------------|-------|--------|-------|---------------------------|
| | MIN | MAX | MIN | MAX | |
| A | 4.55 | 4.85 | 0.179 | 0.191 | 0 |
| A1 | 2.55 | 2.85 | 0.100 | 0.112 | 2.5 |
| A2 | 2.42 | 2.72 | 0.095 | 0.107 | 5mm |
| b | 0.65 | 0.85 | 0.026 | 0.033 | |
| b1 | 0.95 | 1.33 | 0.037 | 0.052 | |
| b2 | 0.95 | 1.51 | 0.037 | 0.059 | |
| b3 | 0.65 | 1.33 | 0.026 | 0.052 | |
| b4 | 0.65 | 1.51 | 0.026 | 0.059 | |
| c | 0.40 | 0.63 | 0.016 | 0.025 | |
| D | 15.85 | 16.15 | 0.624 | 0.636 | |
| D1 | 9.53 | 9.83 | 0.375 | 0.387 | |
| E | 10.35 | 10.65 | 0.407 | 0.419 | |
| e | 2.54 | | 0.100 | | |
| e1 | 5.08 | | 0.200 | | |
| N | 3 | | 3 | | |
| H | 29.45 | 29.75 | 1.159 | 1.171 | |
| L | 13.45 | 13.75 | 0.530 | 0.541 | |
| L1 | 3.15 | 3.45 | 0.124 | 0.136 | |
| ØP | 2.95 | 3.20 | 0.116 | 0.126 | |
| Q | 3.15 | 3.50 | 0.124 | 0.138 | |

| | |
|---------------------------------|-----------------|
| REFERENCE ... SCALE | 0 2.5 5mm |
| EUROPEAN PROJECTION | |
| | |
| ISSUE DATE 08-01-2007 | |
| FILE T0220_2 | |

Published by
Infineon Technologies AG
81726 Munich, Germany
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